



SCOPE OF ACCREDITATION TO ISO/IEC 17025:2017
& ANSI/NCSL Z540-1-1994

HERMON LABORATORIES
68 Hatachana Street
(Postal Mail to P.O. Box 23)
Binyamina, 3055001, ISRAEL
Mr. George Shleimovich Phone: 972 4 6288 001
Email: mail@hermonlabs.com

CALIBRATION

Valid To: May 31, 2021

Certificate Number: 0839.03

In recognition of the successful completion of the A2LA evaluation process, accreditation is granted to this laboratory to perform the following calibrations^{1,8}:

I. Electrical – DC/Low Frequency

Parameter/Equipment	Range	CMC ^{2,4,7} (±)	Comments ⁵
DC Voltage – Generate	0.01 mV to 1 V (1.0 to 10) V (10.0 to 100) V (100.0 to 1000) V	16 µV/V + 0.64 µV 16 µV/V + 2.7 µV 16 µV/V + 50 µV 16 µV/V + 15 mV	Wavetek 9000 calibrator & Agilent 3458A
DC Voltage – Measure	0.01 mV to 1 V (1.0 to 10) V (10.0 to 100) V (100.0 to 1000) V	16 µV/V + 0.37 µV 16 µV/V + 0.90 µV 16 µV/V + 38 µV 16 µV/V + 14 mV	Agilent 3458A
DC Current – Generate	(0.01 to 1.0) µA (1.0 to 10.0) µA (10.0 to 100) µA 100.0 µA to 1.0 mA (1.0 to 10.0) mA (10.0 to 100.0) mA 100 mA to 1.0 A	29 µA/A + 0.7 nA 29 µA/A + 0.7 nA 29 µA/A + 1.2 nA 29 µA/A + 0.0086 µA 29 µA/A + 0.078 µA 46 µA/A + 0.58 µA 0.013 % + 13 µA	Wavetek 9000 calibrator & Agilent 3458A



Parameter/Equipment	Range	CMC ^{2,4,7} (\pm)	Comments ⁵
DC Current – Measure	(1 to 100) nA 100 nA to 1.0 μ A (1.0 to 10.0) μ A (10.0 to 100.0) μ A 100.0 μ A to 1.0 mA (1.0 to 10.0) mA (10.0 to 100.0) mA 100.0 mA to 1.0 A	40 μ A/A + 0.05 nA 29 μ A/A + 0.05 nA 29 μ A/A + 0.12 nA 29 μ A/A + 0.92 nA 29 μ A/A + 0.006 μ A 29 μ A/A + 0.06 μ A 46 μ A/A + 0.6 μ A 0.013 % + 13 μ A	Agilent 3458A
Resistance – Generate	(0.1 to 10) Ω (10 to 100) Ω 100 Ω to 1 k Ω (1 to 10) k Ω (10 to 100) k Ω 100 k Ω to 1 M Ω (1 to 10) M Ω (10 to 100) M Ω 100 M Ω to 1 G Ω	23 $\mu\Omega/\Omega$ + 0.14 m Ω 23 $\mu\Omega/\Omega$ + 1.3 m Ω 18 $\mu\Omega/\Omega$ + 1.3 m Ω 18 $\mu\Omega/\Omega$ + 13 m Ω 18 $\mu\Omega/\Omega$ + 0.13 Ω 23 $\mu\Omega/\Omega$ + 7.2 Ω 85 $\mu\Omega/\Omega$ + 0.19 k Ω 0.12 % + 2.6 k Ω 1.2 % + 51 k Ω	JJ Instruments R702 Resistor box (up to 1 M Ω), time electronics 8000-decade resistance (up to 90 M Ω), HL 4084 resistor set (up to 1 G Ω) & Agilent 3458A
Resistance – Measure	(0.001 to 10) Ω (10 to 100) Ω 100 Ω to 1 k Ω (1 to 10) k Ω (10 to 100) k Ω 100 k Ω to 1 M Ω (1 to 10) M Ω (10 to 100) M Ω 100 M Ω to 1 G Ω	23 $\mu\Omega/\Omega$ + 0.14 m Ω 23 $\mu\Omega/\Omega$ + 1.3 m Ω 18 $\mu\Omega/\Omega$ + 1.3 m Ω 18 $\mu\Omega/\Omega$ + 13 m Ω 18 $\mu\Omega/\Omega$ + 0.13 Ω 23 $\mu\Omega/\Omega$ + 7.2 Ω 85 $\mu\Omega/\Omega$ + 0.19 k Ω 0.12 % + 2.6 k Ω 1.2 % + 51 k Ω	Agilent 3458A 4-wire method

Parameter/Range	Frequency	CMC ^{2,4,7} (\pm)	Comments ⁵
AC Voltage – Generate (1 to 10) mV (10 to 100) mV (0.1 to 1) V (1 to 10) V (10 to 100) V	(1 to 40) Hz	0.034 % + 0.004 mV 0.008 % + 0.006 mV 0.008 % + 0.05 mV 0.008 % + 0.46 mV 0.023 % + 4.6 mV	Wavetek 9000 calibrator & Agilent 3458A

Parameter/Range	Frequency	CMC ^{2, 4, 7} (\pm)	Comments ⁵
AC Voltage – Generate (cont)			
(1 to 10) mV (10 to 100) mV (0.1 to 1) V (1 to 10) V (10 to 100) V	(1 to 40) Hz	0.034 % + 0.004 mV 0.008 % + 0.006 mV 0.008 % + 0.05 mV 0.008 % + 0.46 mV 0.023 % + 4.6 mV	Wavetek 9000 calibrator & Agilent 3458A
(1 to 10) mV (10 to 100) mV (0.1 to 1) V (1 to 10) V (10 to 100) V (100 to 700) V	40 Hz to 1 kHz	0.023 % + 1.3 μ V 0.008 % + 2.8 μ V 0.008 % + 31 μ V 0.008 % + 0.28 mV 0.023 % + 2.7 mV 0.045 % + 19 mV	
(1 to 10) mV (10 to 100) mV (0.1 to 1) V (1 to 10) V (10 to 100) V (100 to 700) V	(1 to 20) kHz	0.034 % + 1.3 μ V 0.016 % + 2.8 μ V 0.016 % + 3.1 μ V 0.016 % + 0.28 mV 0.023 % + 2.7 mV 0.068 % + 19 mV	
(1 to 10) mV (10 to 100) mV (0.1 to 1) V (1 to 10) V (10 to 100) V	(20 to 50) kHz	0.12 % + 1.4 μ V 0.034 % + 3.3 μ V 0.034 % + 23 μ V 0.034 % + 0.23 mV 0.040 % + 2.4 mV	
(1 to 10) mV (10 to 100) mV (0.1 to 1) V (1 to 10) V (10 to 100) V	(50 to 100) kHz	0.57 % + 1.5 μ V 0.092 % + 3.4 μ V 0.092 % + 24 μ V 0.092 % + 0.25 mV 0.14 % + 2.9 mV	
AC Voltage – Measure			
(1 to 10) mV (10 to 100) mV (0.1 to 1) V (1 to 10) V (10 to 100) V (100 to 700) V	(1 to 40) Hz	0.034 % + 0.003 mV 0.008 % + 0.005 mV 0.008 % + 0.046 mV 0.008 % + 0.45 mV 0.023 % + 4.5 mV 0.045 % + 45 mV	Agilent 3458A
(1 to 10) mV (10 to 100) mV (0.1 to 1) V (1 to 10) V	40 Hz to 1 kHz	0.023 % + 2.0 μ V 0.008 % + 2.8 μ V 0.008 % + 23 μ V 0.008 % + 0.23 mV	

Parameter/Range	Frequency	CMC ^{2, 4, 7} (\pm)	Comments ⁵	
AC Voltage – Measure (cont)				
(10 to 100) V (100 to 700) V	40 Hz to 1 kHz	0.023 % + 2.3 mV 0.045 % + 16 mV	Agilent 3458A	
(1 to 10) mV (10 to 100) mV (0.1 to 1) V (1 to 10) V (10 to 100) V (100 to 700) V	(1 to 20) kHz	0.034 % + 2.0 μ V 0.016 % + 2.8 μ V 0.016 % + 23 μ V 0.016 % + 0.23 mV 0.023 % + 2.3 mV 0.068 % + 16 mV		
(1 to 10) mV (10 to 100) mV (0.1 to 1) V (1 to 10) V (10 to 100) V (100 to 700) V	(20 to 50) kHz	0.12 % + 1.3 μ V 0.034 % + 2.6 μ V 0.034 % + 23 μ V 0.034 % + 0.23 mV 0.040 % + 2.3 mV 0.14 % + 16 mV		
(1 to 10) mV (10 to 100) mV (0.1 to 1) V (1 to 10) V (10 to 100) V (100 to 700) V	(50 to 100) kHz	0.57 % + 1.5 μ V 0.091 % + 2.9 μ V 0.091 % + 24 μ V 0.091 % + 0.24 mV 0.14 % + 2.4 mV 0.34 % + 17 mV		
AC Current – Generate				
(10 to 100) μ A (0.1 to 1) mA (1 to 10) mA (10 to 100) mA (0.1 to 1) A	(10 to 20) Hz	0.46 % + 0.034 μ A 0.46 % + 0.23 μ A 0.46 % + 2.3 μ A 0.46 % + 23 μ A 0.46 % + 0.23 mA		Wavetek 9000 Calibrator, Wavetek 174 & Agilent 3458A
(10 to 100) μ A (0.1 to 1) mA (1 to 10) mA (10 to 100) mA (0.1 to 1) A	(20 to 45) Hz	0.17 % + 0.034 μ A 0.17 % + 0.23 μ A 0.17 % + 2.3 μ A 0.17 % + 23 μ A 0.18 % + 0.23 mA		
(10 to 100) μ A (0.1 to 1) mA (1 to 10) mA (10 to 100) mA (0.1 to 1) A	(45 to 100) Hz	0.068 % + 0.034 μ A 0.068 % + 0.23 μ A 0.068 % + 2.3 μ A 0.068 % + 23 μ A 0.091 % + 0.23 mA		

Parameter/Range	Frequency	CMC ^{2, 4, 7} (\pm)	Comments ⁵
AC Current – Generate (cont)			
(10 to 100) μ A (0.1 to 1) mA (1 to 10) mA (10 to 100) mA (0.1 to 1) A	100 Hz to 5 kHz	0.068 % + 0.034 μ A 0.035 % + 0.23 μ A 0.035 % + 2.3 μ A 0.035 % + 23 μ A 0.12 % + 0.23 mA	Wavetek 9000 calibrator & Agilent 3458A
(0.1 to 1) mA (1 to 10) mA (10 to 100) mA	(5 to 20) kHz	0.068 % + 0.23 μ A 0.068 % + 2.3 μ A 0.068 % + 23 μ A	
(0.1 to 1) A	(5 to 10) kHz	0.34 % + 0.23 mA	
(0.1 to 1) mA (1 to 10) mA (10 to 100) mA	(20 to 50) kHz	0.46 % + 0.45 μ A 0.46 % + 4.5 μ A 0.46 % + 45 μ A	
(0.1 to 1) mA (1 to 10) mA (10 to 100) mA	(50 to 100) kHz	0.63 % + 1.7 μ A 0.63 % + 17 μ A 0.63 % + 0.17 mA	
AC Current – Measure			
(10 to 100) μ A (0.1 to 1) mA (1 to 10) mA (10 to 100) mA (0.1 to 1) A	(10 to 20) Hz	0.46 % + 0.034 μ A 0.46 % + 0.23 μ A 0.46 % + 2.3 μ A 0.46 % + 23 μ A 0.46 % + 0.23 mA	Agilent 3458A
(10 to 100) μ A (0.1 to 1) mA (1 to 10) mA (10 to 100) mA (0.1 to 1) A	(20 to 45) Hz	0.17 % + 0.034 μ A 0.17 % + 0.23 μ A 0.17 % + 2.3 μ A 0.17 % + 23 μ A 0.18 % + 0.23 mA	
(10 to 100) μ A (0.1 to 1) mA (1 to 10) mA (10 to 100) mA (0.1 to 1) A	(45 to 100) Hz	0.068 % + 0.034 μ A 0.068 % + 0.23 μ A 0.068 % + 2.3 μ A 0.068 % + 23 μ A 0.091 % + 0.23 mA	
(10 to 100) μ A (0.1 to 1) mA (1 to 10) mA (10 to 100) mA (0.1 to 1) A	100 Hz to 5 kHz	0.068 % + 0.034 μ A 0.035 % + 0.23 μ A 0.035 % + 2.3 μ A 0.035 % + 23 μ A 0.12 % + 0.23 mA	

Parameter/ Range	Frequency	CMC ^{2,4,7} (±)	Comments ⁵
AC Current – Measure (cont) (0.1 to 1) mA (1 to 10) mA (10 to 100) mA (0.1 to 1) A (0.1 to 1) mA (1 to 10) mA (10 to 100) mA (0.1 to 1) A (0.1 to 1) mA (1 to 10) mA (10 to 100) mA	(5 to 20) kHz (20 to 50) kHz (50 to 100) kHz	0.068 % + 0.23 µA 0.068 % + 2.3 µA 0.068 % + 23 µA 0.34 % + 0.23 mA 0.46 % + 0.45 µA 0.46 % + 4.5 µA 0.46 % + 45 µA 1.2 % + 0.45 mA 0.63 % + 1.7 µA 0.63 % + 17 µA 0.63 % + 0.17 mA	Agilent 3458A
AC High Voltage – Measure (0.7 to 10) kV	(50,60) Hz	(0.22 to 0.97) %	Tektronix P6015A, Agilent 3458A, Wavetek 9000, Associated Research 3670
DC High Voltage – Measure (1 to 10) kV	DC	(0.042 to 0.21) %	Tektronix P6015A, Agilent 3458A, Wavetek 9000, Associated Research 3670

II. Electrical – RF/Microwave

Parameter/Equipment	Frequency	CMC ² (±)	Comments ⁵
Biconical Antenna – 3 m 10 m Antennae Factor, Horizontal Polarization	(30 to 300) MHz (30 to 300) MHz	1.5 dB 1.5 dB	ANSI C63.5-1998 (SSM) ANSI C63.5-1998 (SSM) ANSI C63.5-2006, excluding Appendix H (RAM)

Parameter/Equipment	Frequency	CMC ² (±)	Comments ⁵
Log Periodic Antenna – 3 m 10 m Antenna Factor, Horizontal Polarization	(200 to 3000) MHz (200 to 1000) MHz	1.5 dB 1.5 dB	ANSI C63.5-1998 (SSM) ANSI C63.5-1998 (SSM) ANSI C63.5-2006, excluding Appendix H (RAM)
Dipole Antenna – 3 m 10 m Antenna Factor, Horizontal Polarization	(30 to 1000) MHz (30 to 1000) MHz	1.5 dB 1.5 dB	ANSI C63.5-1998 (SSM) ANSI C63.5-1998 (SSM) ANSI C63.5-2006 (RAM)
Hybrid Broadband Antenna – 3 m 10 m Antenna Factor, Horizontal Polarization	(30 to 3000) MHz (30 to 1000) MHz	1.5 dB 1.5 dB	ANSI C63.5-1998 (SSM) ANSI C63.5-1998 (SSM) ANSI C63.5-2006, excluding Appendix H (RAM)
Horn Antennas – 1 m, 3 m Antenna Factor, Horizontal & Vertical Polarization	(1 to 18) GHz (18 to 40) GHz	0.7 dB 1.1 dB	SAE ARP 958D, Appendix C, ANSI C63.5-2017(SSM) Agilent E4407B, E4446A, Rohde & Schwarz NRP- Z91, NRP-Z31, NRP-Z56

Parameter/Equipment	Frequency	CMC ^{2,4} (±)	Comments ⁵
Linear Polarized Broadband Antennas – 1 m Antenna Factor, Horizontal & Vertical Polarization	(20 to 2000) MHz (1 to 18) GHz (18 to 40) GHz	1.2 dB 1.1 dB 1.7 dB	SAE ARP958D Agilent E4407B, E4446A and R&S SMB100A
Log Spiral Antennas – 1 m Antenna Factor	(0.2 to 10) GHz	1.3 dB	SAE ARP958D Agilent E4407B, E4446A and R&S SMB100A
Rod (Monopole) – Antennas Antenna Factor	9 kHz to 30 MHz	0.75 dB	IEEE Std 291-1991, SAE ARP958D, ANSI C63.5-2017 (ECSM), HP 4195A
Loop Antennas – Antenna Factor	20 Hz to 500 kHz	0.22 dB	IEEE 1309, IEEE 291-1992 Helmholtz Coil, Agilent E4446A and Pearson 110 A
Magnetic Field Probes – 0.5 mG to 3 G	10 Hz to 500 kHz	2.4 %	IEEE 1309, IEEE 291-1992 Helmholtz Coil Fluke A40A and Agilent 3458A or Agilent E4446A and Pearson 110 A
ELF Electric Field Probes – 50 V/m to 5 kV/m	(16 to 300) Hz	1.5 %	IEEE 1308-1994 Parallel Plates

Parameter/Equipment	Frequency	CMC ^{2, 3, 4} (\pm)	Comments ⁵
Line Impedance Stabilization Network (LISN) –			
Impedance Magnitude	(0.009 to 300) kHz (0.3 to 400) MHz	(0.35 to 1.7) % 1.9 %	CISPR 16-1-2 CISPR 25 (2008) ANSI C63.4-2014, Annex E, MIL-STD 461 RTCA/DO-160 MIL-STD 462 ISO 7637-2
Impedance Phase	(0.009 to 300) kHz (0.3 to 108) MHz	(0.24 to 0.7) ° 1.1°	
Voltage Division Factor	(0.009 to 400) MHz	0.08 dB	
HIOKI 3532-50 LCR HiTESTER, HP 4195A, & HP41951A			
Bulk Current Injection Probes –			
Insertion loss	10 Hz to 500 MHz	0.3 dB + <i>M</i>	MIL STD-461 IEC 61000-4-6 CISPR 16-1-2 Agilent 3458A, HP 4195
Current Probes –			
Transfer Impedance	10 Hz to 500 MHz 500 MHz to 1 GHz	0.3 dB + <i>M</i> 0.75 dB + <i>M</i>	IEC 61000-4-6 CISPR 16-1-2 Agilent 3458A, HP 4195, Rhode & Schwarz NRP –Z91
Electromagnetic Field Sensors & Probes –			
Frequency response, Linearity	10 kHz to 200 MHz 250 to 400 MHz 400 MHz to 18 GHz (18 to 40) GHz	0.75 dB 1.8 dB 1.4 dB 1.8 dB	IEEE 1309 TEM-cell CC-103SEX, Anechoic chamber with double ridged wave guide & standard gain horn antennas

Parameter/Equipment	Frequency	CMC ^{2,3,4,7} (\pm)	Comments ⁵	
Electrical Pulse – Measure				
Amplitude	Up to 4 kV	2.7 %	LeCroy LC584AL	
Transition time, duration	2 ns to 500 ms	3 %		
RF Power – Measure				
0 dBm, 1 mW reference	50 MHz	0.58 % + <i>M</i>	Rohde & Schwarz NRP-Z56	
(-20 to 20) dBm (Absolute)	DC to 100 MHz (0.1 to 8) GHz (8 to 12.4) GHz (12.4 to 26.5) (26.5 to 40) GHz (40 to 50) GHz	0.93 % + <i>M</i> 1.3 % + <i>M</i> 1.5 % + <i>M</i> 2 % + <i>M</i> 2.4 % + <i>M</i> 3.3 % + <i>M</i>		
(-19 to 1) dBm (Absolute)	9 kHz to 4 GHz (4 to 26.5) GHz (26.5 to 33) GHz	1.5 % + <i>M</i> 2.1 % + <i>M</i> 2.8 % + <i>M</i>		Rohde & Schwarz NRP-Z91 & NRP-Z31
(-19 to -55, +1 to 20) dBm (Absolute)	9 kHz to 4 GHz (4 to 26.5) GHz (26.5 to 33) GHz	1.5 % + <i>M</i> 2.3 % + <i>M</i> 3.2 % + <i>M</i>		
RF Power – Measure (cont.)				
(-90 to -20) dBm (Absolute)	10 Hz to 100 MHz (0.1 to 8) GHz (8 to 12.4) GHz (12.4 to 33) GHz (33 to 40) GHz	2.8 % + <i>M</i> 3.3 % + <i>M</i> 5.3 % + <i>M</i> 5.6 % + <i>M</i> 7.4 % + <i>M</i>	Rohde & Schwarz NRP-Z56, Agilent E4446A	
RF Power – Measure				
(0.01 to 1000) W (0.1 to 500) W (0.1 to 50) W (0.1 to 50) W (0.1 to 2) W (0.1 to 2) W	10 kHz to 100 MHz (0.1 to 2.4) GHz (2.4 to 8) GHz (8 to 18) GHz (26.5 to 40) GHz (26.5 to 40) GHz	1.4 % + <i>M</i> 1.9 % + <i>M</i> 2.1 % + <i>M</i> 3 % + <i>M</i> 4.6 % + <i>M</i> 5.2 % + <i>M</i>	Rohde & Schwarz NRP-Z56, NRP-Z91, & NRP-Z31, directional couplers, attenuators	

Parameter/Equipment	Frequency	CMC ^{2, 3, 4, 7} (\pm)	Comments ⁵
RF Power – Linearity (relative power) (0 to 30) dB (0 to 60) dB (60 to 70) dB (70 to 120) dB	10 Hz to 40 GHz 10 Hz to 40 GHz 10 Hz to 500 MHz 10 Hz to 500 MHz	0.011 dB 0.016 dB 0.08 dB 0.13 dB	Tabor Electronics WW5062, Rohde & Schwarz SML03, SMB100A, & NRP-Z56 HP 355D, HP 355C
Harmonics – Measure (generators and spectrum analyzers)	10 Hz to 1500 MHz (1.5 to 3.3) GHz (3.3 to 11) GHz (11 to 18) GHz	0.45 dB 0.64 dB 0.94 dB 1.11 dB	Agilent E4446A
Resolution bandwidth accuracy and selectivity		0.9 %	Rohde & Schwarz SMB- 100A, NRP-Z56, Hewlett Packard 355D, HP355C
Frequency readout accuracy	9 kHz to 40 GHz	0.2 μ Hz/Hz	Rohde & Schwarz SMB- 100A / SML3
Frequency marker count accuracy ⁶	9 kHz to 40 GHz	0.6 pHz/Hz	
Frequency span accuracy	9 kHz to 40 GHz	0.35 %	Rohde & Schwarz SMB- 100A / SML3, Keysight N5173B
Sweep time accuracy	100 μ s to 10 s	0.35 %	Rohde & Schwarz SMB- 100A / SML3, Tabor Electronics WW5062
Residual FM	Up to 350 Hz	10 %	
Third order intermodulation distortion (TOI)	1 MHz to 40 GHz	0.59 dB	Rohde & Schwarz SMB- 100A, Keysight N5173B
Gain compression	1 MHz to 40 GHz	0.06 dB	
Display average noise level	10 Hz to 40 GHz	0.29 dB	

Parameter/Equipment	Frequency	CMC ^{2, 3, 4, 7} (\pm)	Comments ⁵	
Noise Sidebands (Phase Noise)	10 MHz to 3 GHz	0.58 dB	Rohde & Schwarz SMB-100A	
System-related sidebands	1 MHz to 40 GHz	0.58 dB		
Input-related spurious responses	1 MHz to 40 GHz	0.02 dB		
Residual response	1 MHz to 40 GHz	0.58 dB		
Resolution bandwidth switching uncertainty	1 Hz to 80 MHz RBW	0.29 dB		
Input attenuator switching uncertainty	(0 to 69) dB (69 to 90) dB (1 to 1000) MHz input signal	0.08 dB 0.13 dB		Rohde & Schwarz SMJ 100A, Hewlett Packard 355D, HP355C
Reference level accuracy	(0 to -69) dB (-69 to -90) dB (1 to 1000) MHz input signal	0.08 dB 0.13 dB		
RF Power – Generate				
(-25 to 20) dBm	10 Hz to 100 MHz (0.1 to 2.4) GHz (2.4 to 8) GHz (8 to 12) GHz (12 to 18) GHz (18 to 26.5) GHz (26.5 to 40) GHz	0.97 % + M 1.3 % + M 2 % + M 2.9 % + M 3.7 % + M 4.6 % + M 7.3 % + M	Tabor Electronics WW5062, Rohde & Schwarz SML03, SMB100A, & NRP-Z56	
(-55 to 20) dBm	9 kHz to 2.4 GHz (2.4 to 4) GHz (4 to 8) GHz (8 to 26.5) GHz (26.5 to 33) GHz	1.7 % + M 2 % + M 3.8 % + M 5.5 % + M 8.4 % + M	Rohde & Schwarz SML03, SMB100A, NRP-Z91, & NRP-Z31	
(0.01 to 500) W (0.1 to 50) W (0.1 to 50) W (0.1 to 25) W (0.1 to 25) W	10 kHz to 100 MHz (0.1 to 2.4) GHz (2.4 to 4) GHz (4 to 12) GHz (12 to 18) GHz	1.5 % + M 2.1 % + M 2.7 % + M 4.1 % + M 5.5 % + M	Rohde & Schwarz SML03, SMB100A, & NRP-Z56, power amplifiers & directional couplers	

Parameter/Equipment	Range	CMC ^{2, 3, 4, 7} (\pm)	Comments ⁵
Transmission – Magnitude (Attenuation / Gain)			
DC to 10 kHz	(0 to 45) dB (45 to 65) dB (65 to 80) dB	0.01 dB + <i>M</i> 0.17 dB + <i>M</i> 0.17 dB + <i>M</i>	Rohde & Schwarz NRP-Z56, Agilent E4446A, 3458A, HP4195A
9 kHz to 100 MHz	(0 to 30) dB (30 to 65) dB (65 to 95) dB	0.02 dB + <i>M</i> 0.07 dB + <i>M</i> 0.17 dB + <i>M</i>	Rohde & Schwarz NRP-Z56, NRP-Z91, & NRP-Z31, Agilent E4446A, HP4195A
(50 & 128) MHz	(65 to 110) dB	0.09 dB + <i>M</i>	
100 MHz to 2.4 GHz	(0 to 30) dB (30 to 65) dB (65 to 95) dB	0.02 dB + <i>M</i> 0.07 dB + <i>M</i> 0.18 dB + <i>M</i>	Rohde & Schwarz NRP-Z56, Agilent E4446A, 3458A, HP4195A
(2.4 to 8) GHz	(0 to 30) dB (30 to 65) dB (65 to 95) dB	0.05 dB + <i>M</i> 0.09 dB + <i>M</i> 0.19 dB + <i>M</i>	Rohde & Schwarz NRP-Z56, NRP-Z91, NRP-Z31, Agilent E4446A, HP4195A
(8 to 18) GHz	(0 to 30) dB (30 to 65) dB (65 to 95) dB	0.04 dB + <i>M</i> 0.1 dB + <i>M</i> 0.27 dB + <i>M</i>	
(18 to 26.5) GHz	(0 to 30) dB (40 to 65) dB (65 to 95) dB	0.1 dB + <i>M</i> 0.19 dB + <i>M</i> 0.35dB + <i>M</i>	
(26.5 to 40) GHz	(0 to 30) dB (30 to 65) dB (65 to 90) dB	0.2 dB + <i>M</i> 0.2 dB + <i>M</i> 0.39 dB + <i>M</i>	

Parameter/Range	Frequency	CMC ^{2, 3, 4, 7} (±)	Comments ⁵
<p>Reflection Magnitude –</p> <p>(0 to 1) lin</p> <p>(0 to 1) lin (0 to 1) lin (0 to 1) lin (0 to 1) lin (0 to 1) lin</p>	<p>(0.01 to 500) MHz</p> <p>(0.5 to 2) GHz (2 to 3) GHz (3 to 6) GHz (6 to 9) GHz (9 to 18) GHz</p>	<p>(0.005 to 0.1) lin</p> <p>(0.005 to 0.2) lin (0.005 to 0.35) lin (0.011 to 0.35) lin (0.011 to 0.44) lin (0.025 to 0.44) lin</p>	<p>HP 4195, Agilent 86205A, Mini-Circuits ZFDC-10-6, Agilent 85032E</p> <p>Agilent 8720ES, Agilent 85032E Cal Kit and Keysight 85518A Cal Kit</p>
<p>Impedance – Measure, Magnitude</p> <p>(0.1 to 1) Ω (1 to 10) Ω (0.01 to 10) kΩ (0.01 to 1.0) MΩ, (1 to 10) MΩ</p> <p>(0.001 to 10) kΩ (10 to 100) kΩ (0.1 to 1.0) MΩ</p> <p>(1 to 10) Ω (0.01 to 10) kΩ (10 to 100) kΩ</p> <p>(5 to 2000) Ω</p> <p>(5 to 2000) Ω</p> <p>(5 to 2000) Ω</p> <p>(5 to 2000) Ω</p>	<p>100 Hz to 10 kHz</p> <p>(10.01 to 100) kHz</p> <p>100.1 kHz to 1 MHz</p> <p>100 kHz to 300 kHz</p> <p>(0.3 to 30) MHz</p> <p>(30 to 250) MHz</p> <p>(250 to 500) MHz</p>	<p>(0.48 to 3.26) % (0.24 to 0.41) % (0.10 to 0.24) % (0.18 to 0.57) % (0.47 to 2.3) %</p> <p>(0.24 to 0.41) % (0.30 to 0.54) % (0.35 to 0.95) %</p> <p>(0.47 to 1.2) % (0.35 to 0.5) % (0.47 to 3.3) %</p> <p>(3.5 to 5.7) %</p> <p>(1.9 to 2.9) %</p> <p>(1.9 to 5.1) %</p> <p>(1.9 to 8.5) %</p>	<p>HIOKI 3532-50 LCR HiTESTER</p> <p>HP 4195A, HP 41951, Agilent 85032E</p> <p>HIOKI 3532-50 LCR HiTESTER</p>

Parameter/Range	Frequency	CMC ^{2,3,4,7} (±)	Comments ⁵
Impedance – Measure, Phase (0 to ± 180) ° (0.1 to 1) Ω (1 to 10) Ω (0.01 to 10) kΩ (10 to 100) kΩ (0.1 to 1.0) MΩ (1 to 10) MΩ	100 Hz to 10 kHz	(0.30 to 2.2)° (0.18 to 0.29)° (0.06 to 0.13)° (0.09 to 0.15)° (0.18 to 0.29)° (0.30 to 1.2) °	HIOKI 3532-50 LCR HiTESTER
(1 to 10) Ω (0.01 to 10) kΩ (10 to 100) kΩ (0.1 to 1.0) MΩ	(10.01 to 100) kHz	(0.18 to 0.41)° (0.10 to 0.24)° (0.18 to 0.29)° (0.35 to 0.95)°	
(1 to 10) Ω (0.01 to 10) kΩ (10 to 100) kΩ	100.1 kHz to 1 MHz	(0.35 to 0.66)° (0.18 to 0.29)° (0.35 to 3.23)°	
(5 to 2000) Ω (5 to 2000) Ω (5 to 2000) Ω (5 to 2000) Ω	(100 to 300) kHz (0.3 to 30) MHz (30 to 250) MHz (250 to 500) MHz	(2.0 to 3.3)° (1.1 to 1.7)° (1.1 to 2.9)° (1.1 to 4.9)°	HP4195A, HP41951, Agilent 85032E

III. Thermodynamics

Parameter/Equipment	Range	CMC ^{2,7} (±)	Comments ⁵
Relative Humidity, Fixed Points	10 % RH 50 % RH 95 % RH	0.44 % RH 0.85 % RH 1.2 % RH	Calibration kit EM-15, EDM 15/15 Rotronic & Rotronic EA10, EA50 & EA95 humidity standard
Relative Humidity – Measure	(10 to 95) % RH	2.1 % RH	Rotronic HC2-S & HL- NT2-Dp
Temperature – Measure	(-80 to 100) °C (100 to 200) °C	0.035 °C 0.038 °C	Hart Scientific 5615-6, 1524

Parameter/Equipment	Range	CMC ^{2,7} (\pm)	Comments ⁵
Temperature – Measuring Equipment	(-80 to 100) °C	0.04 °C	Hart Scientific 5615-6, 1524, 7380 Bath
Temperature Uniformity – Measure	(-80 to 100) °C	0.7 °C	Fluke 2625A/2625A w/ thermocouple probes

IV. Time & Frequency

Parameter/Equipment	Range	CMC ^{2,4,7} (\pm)	Comments ⁵
Frequency – Measure & Measuring Equipment	10 MHz (1 to 10) Hz (10 to 100) Hz (100 to 1000) Hz (1 to 10) kHz (10 to 100) kHz (0.1 to 10) MHz (10 to 100) MHz (0.1 to 12.8) GHz (12.8 to 40) GHz	4.8 mHz 0.034 % 0.0034 % 3.4 μ Hz/Hz 0.36 μ Hz/Hz 0.12 μ Hz/Hz 0.12 μ Hz/Hz 0.011 μ Hz/Hz 0.002 μ Hz/Hz 0.004 μ Hz/Hz	Arbiter System Satellite-controlled Clock 1084B, LeCroy LC584AL, HP5327C, Agilent 4446A, Tabor WW5062, R&S SMB100A

¹ This laboratory offers commercial calibration service only.

² Calibration and Measurement Capability Uncertainty (CMC) is the smallest uncertainty of measurement that a laboratory can achieve within its scope of accreditation when performing more or less routine calibrations of nearly ideal measurement standards or nearly ideal measuring equipment. CMCs represent expanded uncertainties expressed at approximately the 95 % level of confidence, usually using a coverage factor of $k = 2$. The actual measurement uncertainty of a specific calibration performed by the laboratory may be greater than the CMC due to the behavior of the customer's device and to influences from the circumstances of the specific calibration.

³ In the statement of CMC, M is the Mismatch error due to connections of calibrated device to calibration set up in actual use.

⁴ In the statement of CMC the percentage is defined as percent of reading.

⁵ Laboratory calibrations are to the current revision/configuration of the applicable standard. Calibration to earlier version or revision of the standard can be provided on request.

⁶ The Frequency marker count accuracy utilizes a Synthesized Sweeper that is phase locked to the DUT and the frequency error is eliminated.

⁷ The type of instrument or material being calibrated is defined by the parameter. This indicates the laboratory is capable of calibrating instruments that measure or generate the values in the ranges indicated for the listed measurement parameter.

⁸ This scope meets A2LA's *P112 Flexible Scope Policy*.



Accredited Laboratory

A2LA has accredited

HERMON LABORATORIES

Binyamina, Israel

for technical competence in the field of

Calibration

This laboratory is accredited in accordance with the recognized International Standard ISO/IEC 17025:2017 *General requirements for the competence of testing and calibration laboratories*. This laboratory also meets the requirements of ANSI/NCSL Z540-1-1994 and R205 – Specific Requirements: Calibration Laboratory Accreditation Program. This accreditation demonstrates technical competence for a defined scope and the operation of a laboratory quality management system (refer to joint ISO-ILAC-IAF Communiqué dated April 2017).



Presented this 22nd day of July 2019.

A blue ink signature of the Vice President of Accreditation Services.

Vice President, Accreditation Services
For the Accreditation Council
Certificate Number 0839.03
Valid to May 31, 2021
Revised July 29, 2019

For the calibrations to which this accreditation applies, please refer to the laboratory's Calibration Scope of Accreditation.